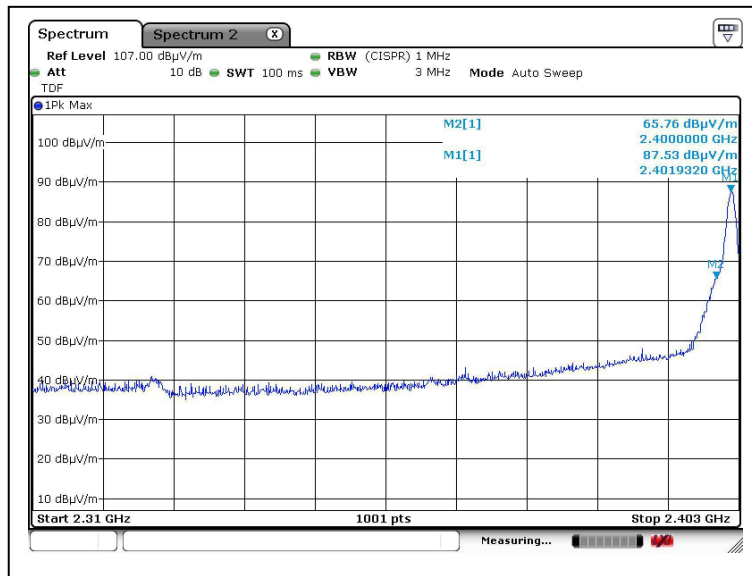


TEST REPORT

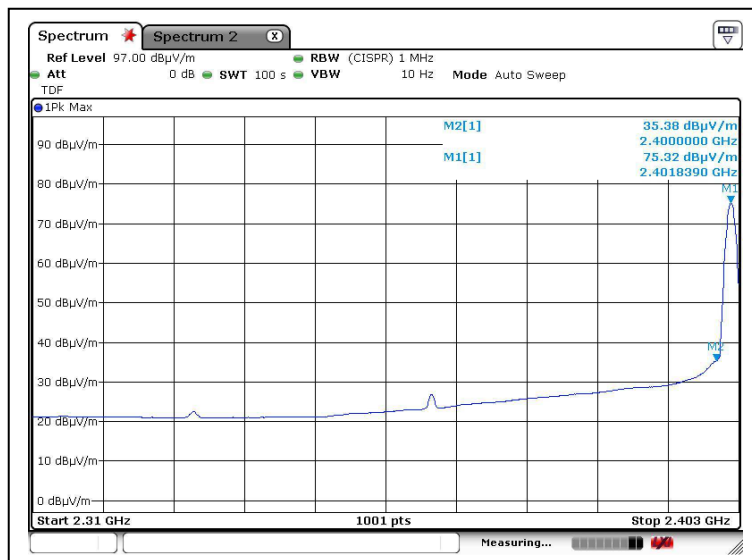
Report No. : AU0006507(7)

Date : 28 Jan 2016

A13. Band Edge



Lower edge (Peak measurement, non-hopping mode)



Lower edge (Average measurement, non-hopping mode)

Tested by:

Mr. LEUNG Shu-kan, Ken

Reviewed by:

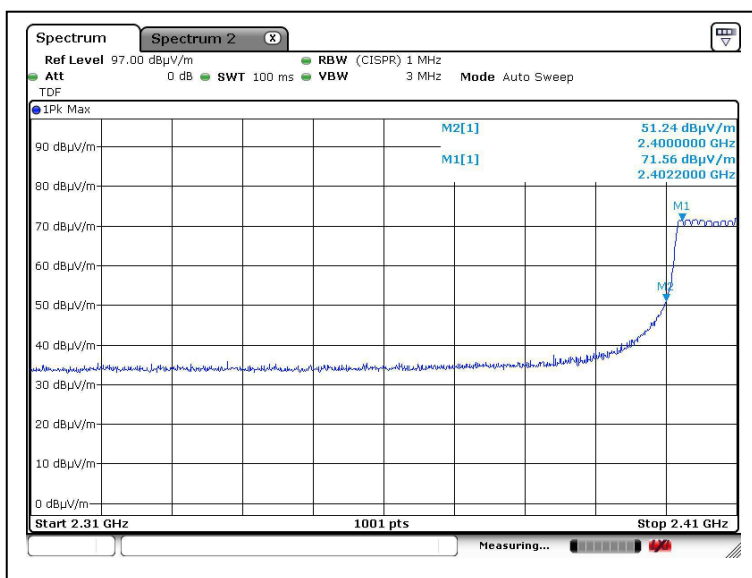
Mr. WONG Lap-pong, Andrew

TEST REPORT

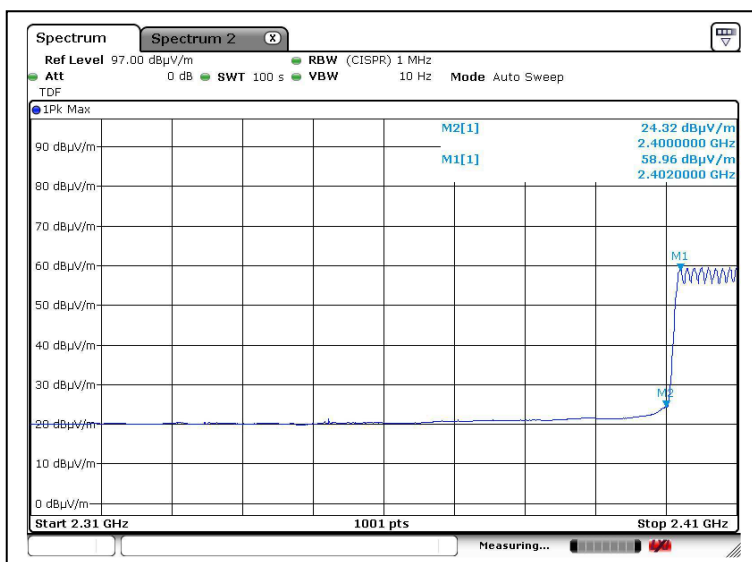
Report No. : AU0006507(7)

Date : 28 Jan 2016

A13. Band Edge



Lower edge (Peak measurement, hopping mode)



Lower edge (Average measurement, hopping mode)

Tested by:

Mr. LEUNG Shu-kan, Ken

Reviewed by:

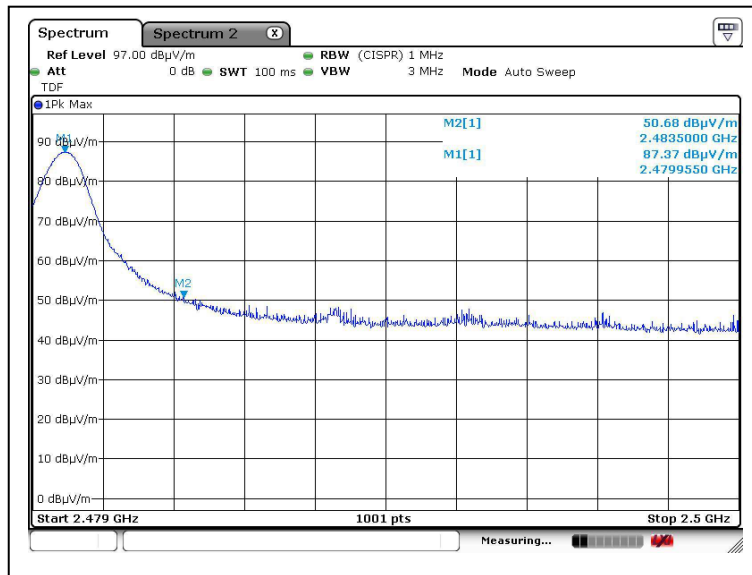
Mr. WONG Lap-pong, Andrew

TEST REPORT

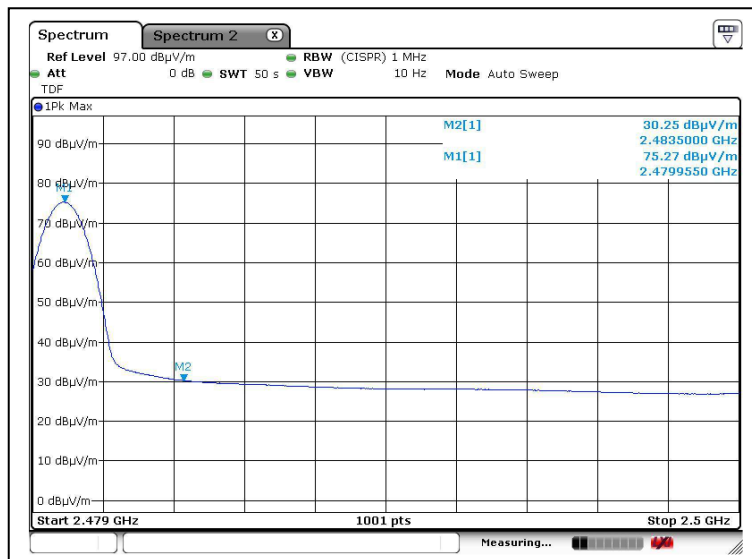
Report No. : AU0006507(7)

Date : 28 Jan 2016

A13. Band Edge



Higher edge (Peak measurement, non-hopping mode)



Higher edge (Average measurement, non-hopping mode)

Tested by:

Mr. LEUNG Shu-kan, Ken

Reviewed by:

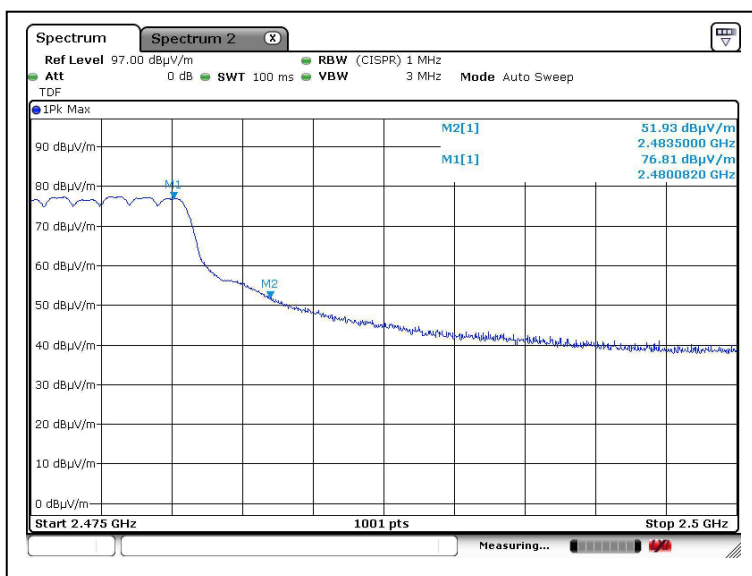
Mr. WONG Lap-pong, Andrew

TEST REPORT

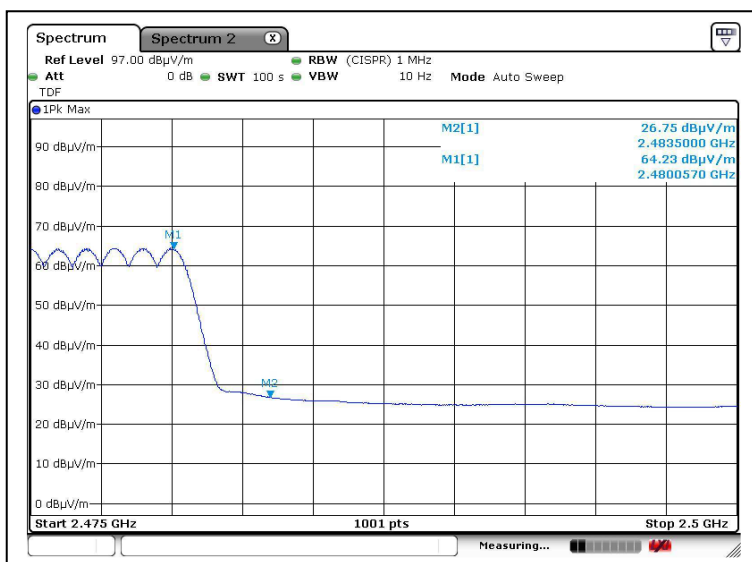
Report No. : AU0006507(7)

Date : 28 Jan 2016

A13. Band Edge



Higher edge (Peak measurement, hopping mode)



Higher edge (Average measurement, hopping mode)

Tested by:

Ken

Mr. LEUNG Shu-kan, Ken

Reviewed by:

PR.

Mr. WONG Lap-pong, Andrew